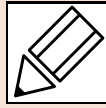


Quick Guide to Precision Measuring Instruments



Quality Control

Quality control (QC)

A system for economically producing products or services of a quality that meets customer requirements.

Process quality control

Activities to reduce variation in product output by a process and keep this variation low. Process improvement and standardization as well as technology accumulation are promoted through these activities.

Statistical process control (SPC)

Process quality control through statistical methods.

Population

A group of all items that have characteristics to be considered for improving and controlling processes and quality of product. A group which is treated based on samples is usually the population represented by the samples.

Lot

Collection of product produced under the same conditions.

Sample

An item of product (or items) taken out of the population to investigate its characteristics.

Sample size

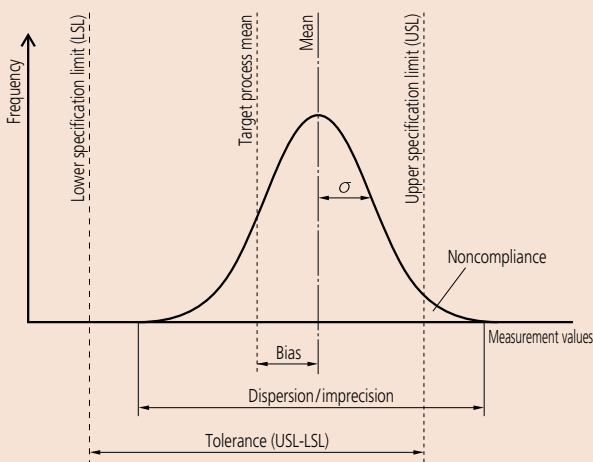
Number of product items in the sample.

Bias

Value calculated by subtracting the true value from the mean of measurement values when multiple measurements are performed.

Dispersion, Imprecision

Variation in the values of a target characteristic in relation to the mean value. Standard deviation is usually used to represent the dispersion of values around the mean.



Histogram

A diagram that divides the range between the maximum and the minimum measurement values into several divisions and shows the number of values (appearance frequency) in each division in the form of a bar graph. This makes it easier to understand the rough average or the approximate extent of dispersion. A bell-shaped symmetric distribution is called the normal distribution and is much used in theoretical examples on account of its easily calculable characteristics. However, caution should be observed because many real processes do not conform to the normal distribution, and error will result if it is assumed that they do.

Process capability

Process-specific performance demonstrated when the process is sufficiently standardized, any causes of malfunctions are eliminated, and the process is in a state of statistical control. The process capability is represented by mean $\pm 3\sigma$ or 6σ when the quality characteristic output from the process shows normal distribution. σ (sigma) indicates standard deviation.

Process capability index (PCI or Cp)

The index value is calculated by dividing the tolerance of a target characteristic by the process capability (6σ). The value calculated by dividing the difference between the mean (\bar{X}) and the standard value by 3σ may be used to represent this index in cases of a unilateral tolerance. The process capability index assumes that a characteristic follows the normal distribution.

Notes: If a characteristic follows the normal distribution, 99.74 % data is within the range $\pm 3\sigma$ from the mean.

Bilateral tolerance

$$C_p = \frac{USL - LSL}{6\sigma}$$

USL: Upper specification limit
LSL: Lower specification limit

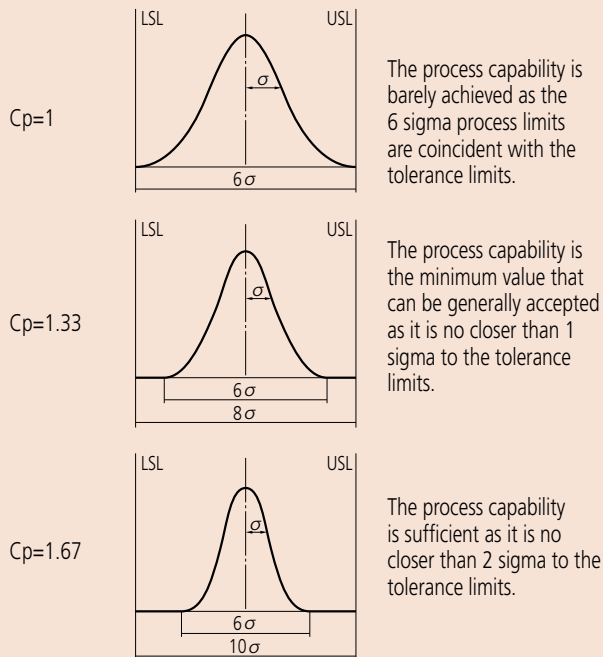
Unilateral tolerance ... If only the upper limit is stipulated

$$C_p = \frac{USL - \bar{X}}{3\sigma}$$

Unilateral tolerance ... If only the lower limit is stipulated

$$C_p = \frac{\bar{X} - LSL}{3\sigma}$$

Specific examples of a process capability index (Cp) (bilateral tolerance)

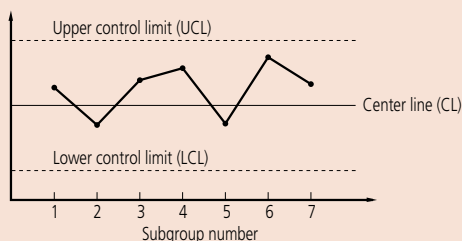


Note that Cp only represents the relationship between the tolerance limits and the process dispersion and does not consider the position of the process mean.

Notes: A process capability index that takes the difference between the process mean from the target process mean into consideration is generally called Cpk, which is the upper tolerance (USL minus the mean) divided by 3σ (half of process capability) or the lower tolerance (the mean value minus LSL) divided by 3σ , whichever is smaller.

Control chart

Used to control the process by separating the process variation into that due to chance causes and that due to a malfunction. The control chart consists of one center line (CL) and the control limit lines rationally determined above and below it (UCL and LCL). It can be said that the process is in a state of statistical control if all points are within the upper and lower control limit lines without notable trends when the characteristic values that represent the process output are plotted. The control chart is a useful tool for controlling process output, and therefore quality.



Chance causes

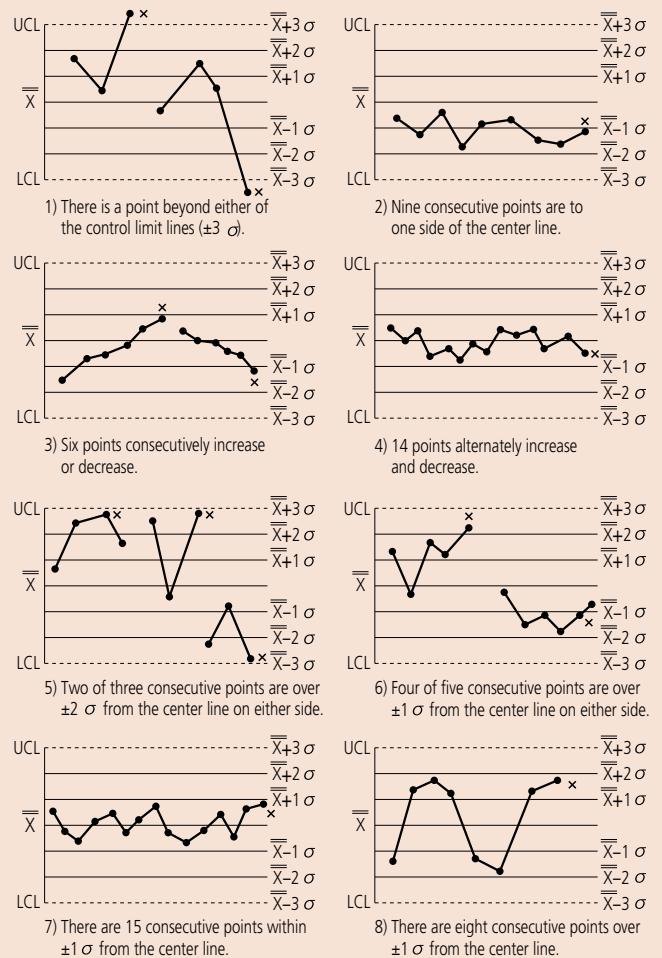
These causes of variation are of relatively low importance. Chance causes are technologically or economically impossible to eliminate even if they can be identified.

\bar{X} -R control chart

A control chart used for process control that provides the most information on the process. The \bar{X} -R control chart consists of the \bar{X} control chart that uses the mean of each subgroup for control to monitor abnormal bias of the process mean and the R control chart that uses the range for control to monitor abnormal variation. Usually, both charts are used together.

How to read the control chart

Typical trends of successive point position in the control chart that are considered undesirable are shown below. These trends are taken to mean that a 'special cause' is affecting the process output and that action from the process operator is required to remedy the situation. These determination rules only provide a guideline. Take the process-specific variation into consideration when actually making determination rules. Assuming that the upper and the lower control limits are 3σ away from the center line, divide the control chart into six regions at intervals of 1σ to apply the following rules. These rules are applicable to the \bar{X} control chart and the \bar{X} control chart. Note that these 'trend rules for action' were formulated assuming a normal distribution. Rules can be formulated to suit any other distribution.



Note: This part of 'Quick Guide to Precision Measuring Instruments' (A-31 to A-32) has been written by Mitutoyo based on its own interpretation of the JIS Quality Control Handbook published by the Japanese Standards Association.

References

- JIS Quality Control Handbook (Japanese Standards Association)

- Z 8101: 1981
- Z 8101-1: 1999
- Z 8101-2: 1999
- Z 9020: 1999
- Z 9021: 1998